



TM150N02NF

N-Channel Enhancement Mosfet

General Description

- Low $R_{DS(ON)}$
- RoHS and Halogen-Free Compliant

Applications

- Load switch
- PWM

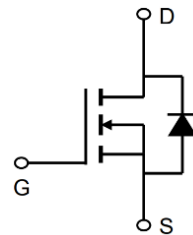
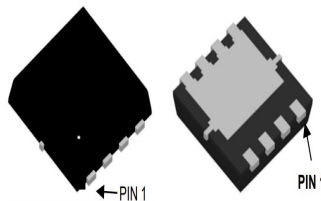
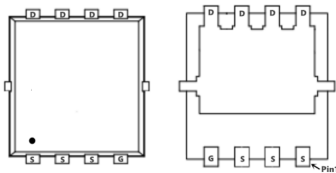
General Features

 $V_{DS} = 20V$ $I_D = 150A$ $R_{DS(ON)} = 1.6m\Omega$ (typ.) @ $V_{GS} = 4.5V$

100% UIS Tested

100% R_g Tested

NF:DFN5x6-8L



Marking: 150N02 OR 20150

Absolute Maximum Ratings ($T_A = 25^\circ C$ Unless Otherwise Noted)

Symbol	Parameter	Rating	Unit
Common Ratings ($T_A = 25^\circ C$ Unless Otherwise Noted)			
V_{DSS}	Drain-Source Voltage	20	V
V_{GSS}	Gate-Source Voltage	± 12	
T_J	Maximum Junction Temperature	150	$^\circ C$
T_{STG}	Storage Temperature Range	-55 to 150	
I_S	Diode Continuous Forward Current	$T_C = 25^\circ C$	A
I_D^a	Continuous Drain Current	$T_C = 25^\circ C$	A
		$T_C = 100^\circ C$	
I_{DM}^b	Pulsed Drain Current	$T_C = 25^\circ C$	360
P_D	Maximum Power Dissipation	$T_C = 25^\circ C$	35
		$T_C = 100^\circ C$	14
$R_{\theta JC}$	Thermal Resistance-Junction to Case	Steady State	3.5
P_D^c	Maximum Power Dissipation	$T_A = 25^\circ C$	1.6
		$T_A = 70^\circ C$	1
$R_{\theta JA}^d$	Thermal Resistance-Junction to Ambient	Steady State	78
I_{AS}^e	Avalanche Current, Single pulse ($L=0.1mH$)	45	A
E_{AS}^e	Avalanche Energy, Single pulse ($L=0.1mH$)	100	mJ

Note a: Package is limited by 50A

b: Pulse width limited by max. junction temperature.

c: $R_{\theta JA}$ steady state=999s.d: $R_{\theta JA}$ steady state=999s. $R_{\theta JA}$ is measured with the device mounted on 1in2, Fr-4 board with 2oz.Copper.e: UIS tested and pulse width limited by maximum junction temperature $150^\circ C$ (initial temperature $T_J = 25^\circ C$).



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Electrical Characteristics ($T_A = 25^\circ\text{C}$ Unless Otherwise Noted)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
Static Characteristics						
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _{DS} =250μA	20	-	-	V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =16V, V _{GS} =0V T _J =85°C	-	-	1 30	μA
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _{DS} =250μA	0.5	0.7	1	V
I _{GSS}	Gate Leakage Current	V _{GS} =±12V, V _{DS} =0V	-	-	±100	nA
R _{DS(ON)} ^g	Drain-Source On-state Resistance	V _{GS} =4.5V, I _{DS} =13.5A V _{GS} =2.5V, I _{DS} =10A	-	1.6 2.5	2.0 3.0	mΩ
Gfs	Forward Transconductance	V _{DS} =5V, I _{DS} =10A	-	34	-	S
Diode Characteristics						
V _{SD} ^d	Diode Forward Voltage	I _{SD} =2A, V _{GS} =0V	-	0.7	1.1	V
t _{rr}	Reverse Recovery Time	I _{SD} =13.5A,	-	18	-	ns
Q _{rr}	Reverse Recovery Charge	dI _{SD} /dt=100A/μs	-	6.2	-	nC
Dynamic Characteristics ^g						
R _G	Gate Resistance	V _{GS} =0V, V _{DS} =0V, f=1MHz	-	2	3.6	Ω
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =10V, Frequency=1.0MHz	-	3275	3910	pF
C _{oss}	Output Capacitance		-	730	-	
C _{rss}	Reverse Transfer Capacitance		-	525	-	
t _{d(ON)}	Turn-on Delay Time	V _{DD} =10V, R _L =10Ω, I _{DS} =1A, V _{GEN} =10V, R _G =6Ω	-	14	26	ns
t _r	Turn-on Rise Time		-	14.5	27	
t _{d(OFF)}	Turn-off Delay Time		-	130	234	
t _f	Turn-off Fall Time		-	70	126	
Gate Charge Characteristics ^g						
Q _g	Total Gate Charge	V _{DS} =10V, V _{GS} =4.5V, I _{DS} =13.5A	-	35	50	nC
Q _{gs}	Gate-Source Charge		-	4.7	-	
Q _{gd}	Gate-Drain Charge		-	11.5	-	

Note f: Pulse test; pulse width $\leq 300\mu s$, duty cycle $\leq 2\%$.

Note g: Guaranteed by design, not subject to production testing.

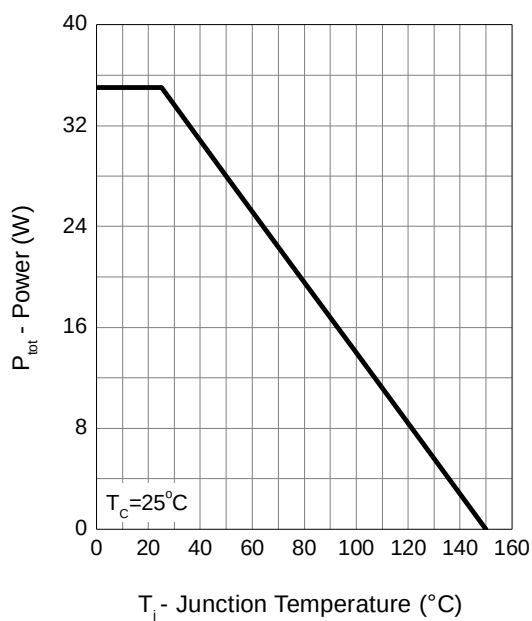


TM150N02NF

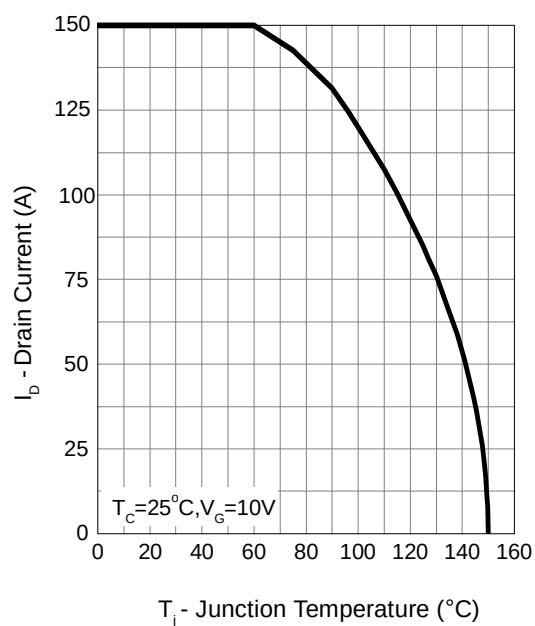
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Typical Operating Characteristics

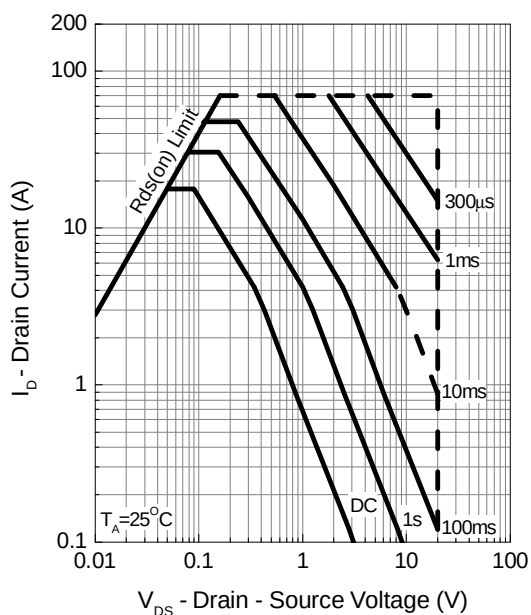
Power Dissipation



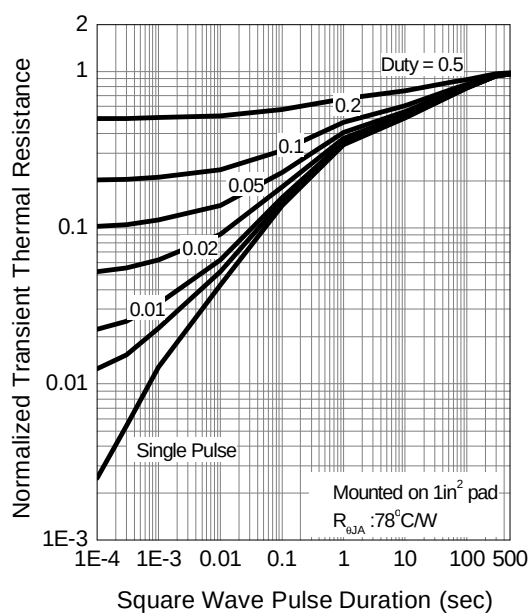
Drain Current



Safe Operation Area



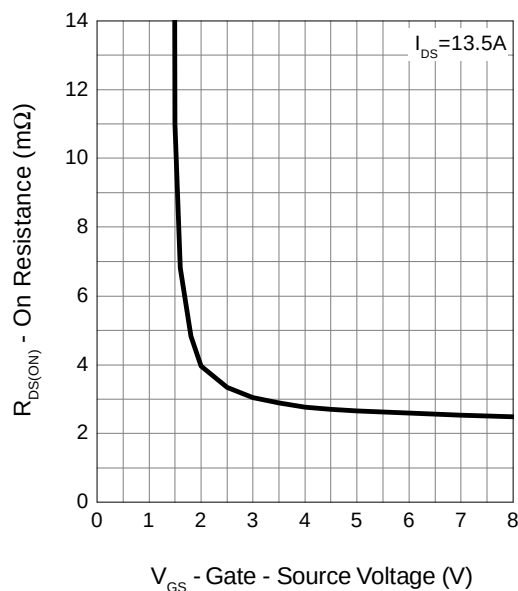
Thermal Transient Impedance



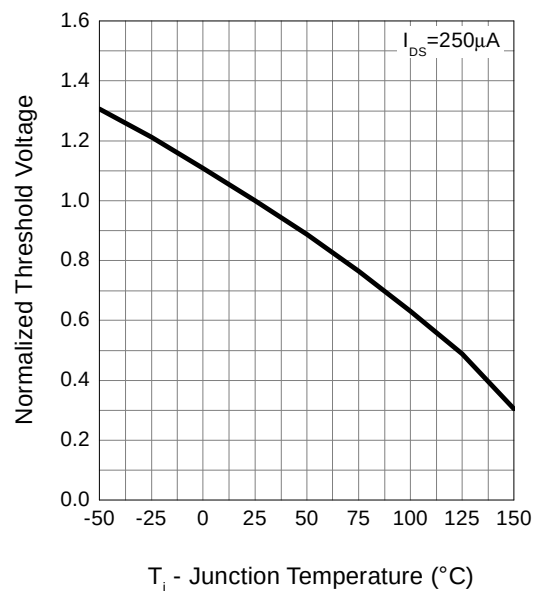
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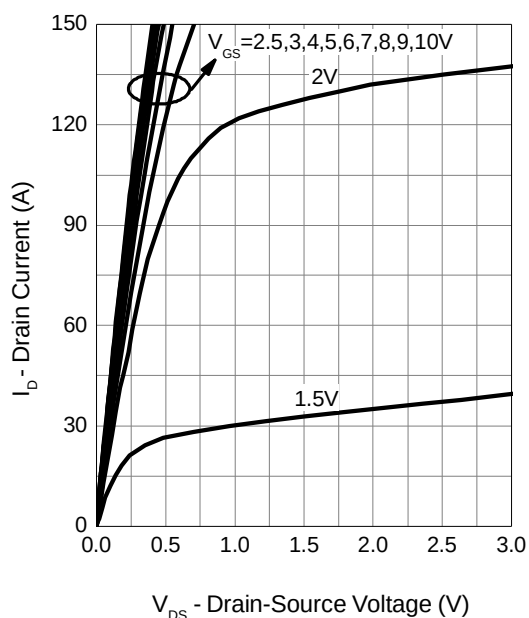
Gate-Source On Resistance



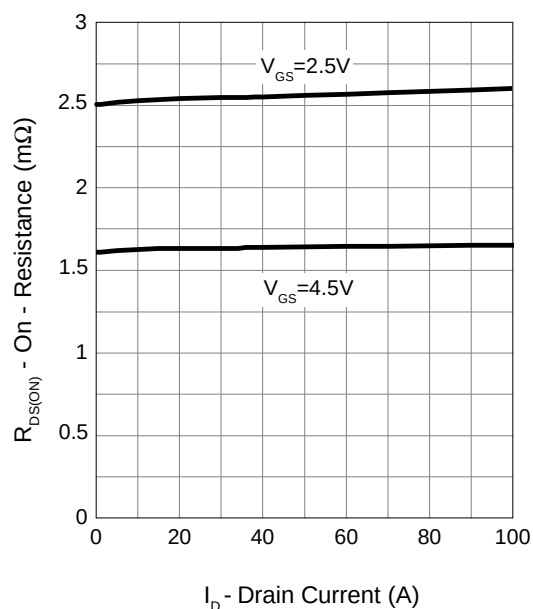
Gate Threshold Voltage



Output Characteristics



Drain-Source On Resistance

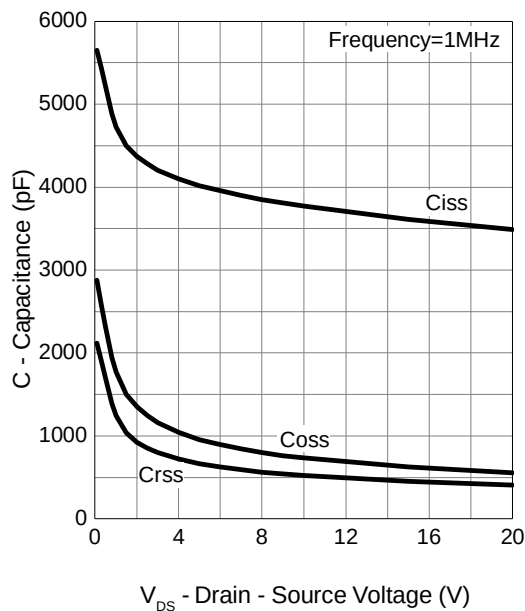




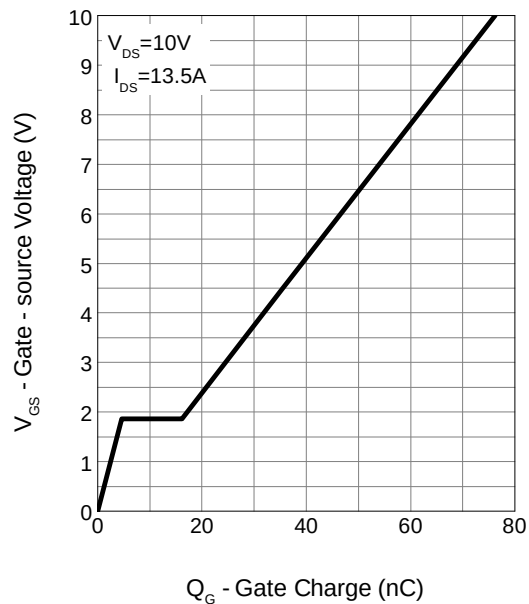
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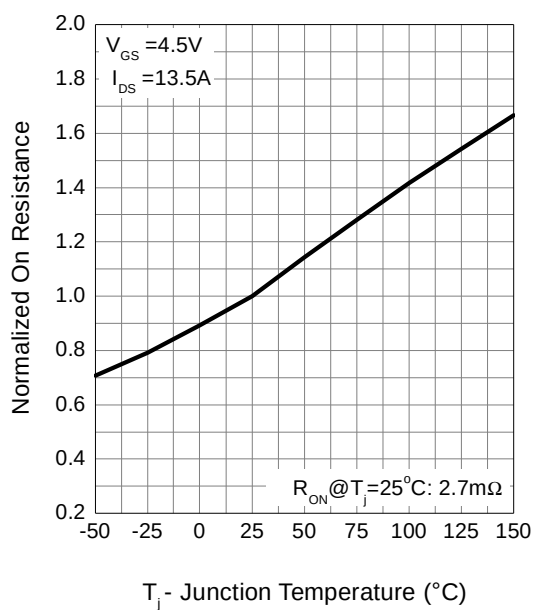
Capacitance



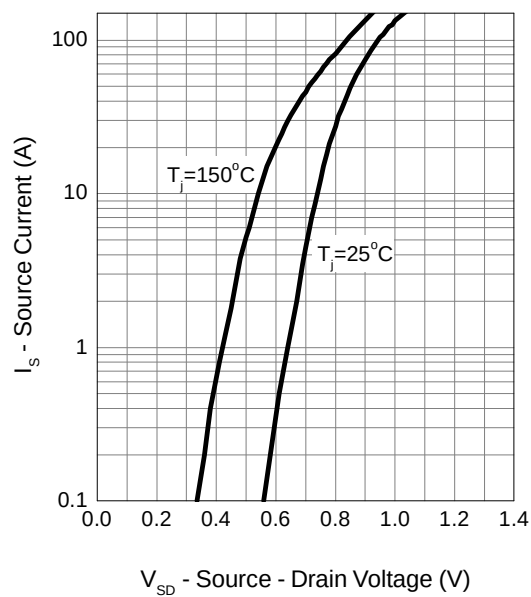
Gate Charge



Drain-Source On Resistance

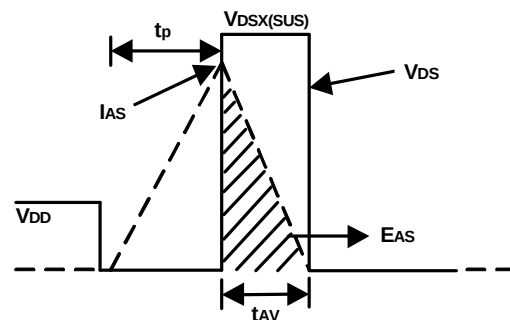
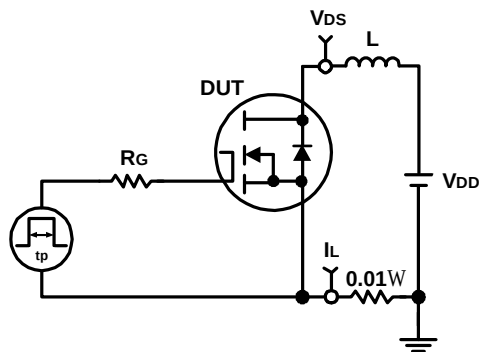


Source-Drain Diode Forward

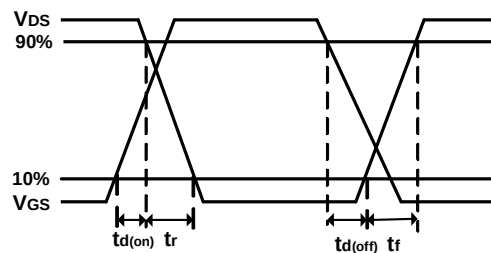
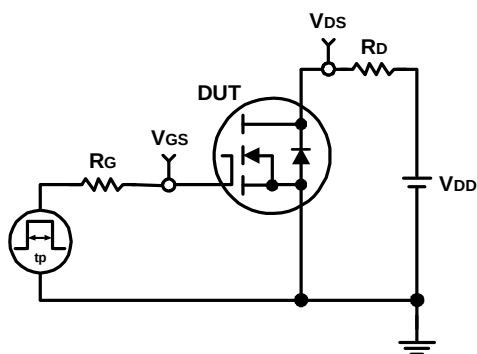




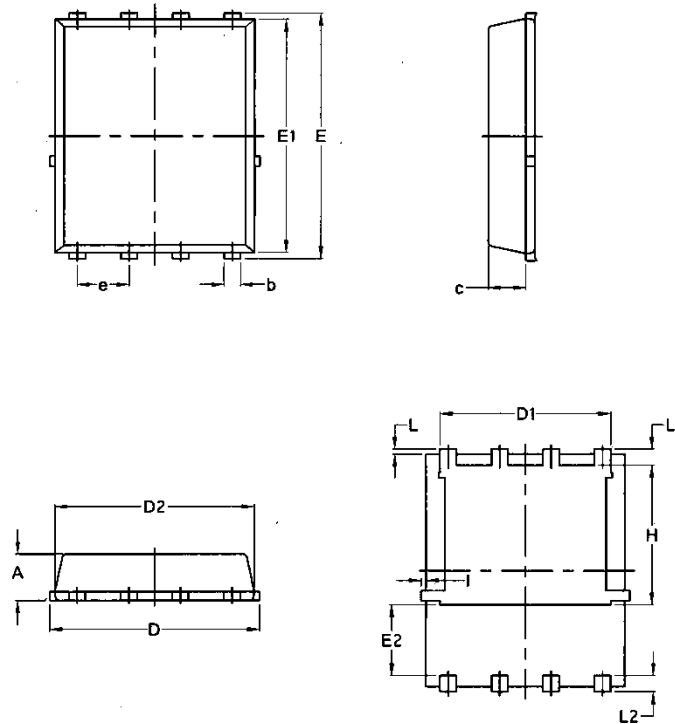
Avalanche Test Circuit and Waveforms



Switching Time Test Circuit and Waveforms



Package Mechanical Data: DFN5x6-8L



Symbol	Common			
	mm		Inch	
	Min	Max	Min	Max
A	1.03	1.17	0.0406	0.0461
b	0.34	0.48	0.0134	0.0189
c	0.824	0.0970	0.0324	0.082
D	4.80	5.40	0.1890	0.2126
D1	4.11	4.31	0.1618	0.1697
D2	4.80	5.00	0.1890	0.1969
E	5.95	6.15	0.2343	0.2421
E1	5.65	5.85	0.2224	0.2303
E2	1.60	/	0.0630	/
e	1.27 BSC		0.05 BSC	
L	0.05	0.25	0.0020	0.0098
L1	0.38	0.50	0.0150	0.0197
L2	0.38	0.50	0.0150	0.0197
H	3.30	3.50	0.1299	0.1378
I	/	0.18	/	0.0070